Feb. 3, 1931.

A. KÖNIG

1,791,276

MICROSCOPE OBJECTIVE

Filed Feb. 8, 1929

T2039

-101.00	φ _r	c ^a t	A			: ·
<i>γ</i> 8 <i>γ</i> 9	1.0	99		T OT I	Δ	1.6200
77 -33.19 ±	d_{II}			001	NI II	1.6073
	$d_{III} \mid b_3$ $14.0 \mid 99.5$		b	Focal length : 100		1.6073 59.5
75 00 + 113.00	62			Focal	#	1.7174
3 74 1.28 +387.(d#	29		P = 1	I	1.5163 64.0
- 87.10 -59.28 +387.00 +113.00 -120.10	$d_T \begin{vmatrix} b_7 \\ 14.0 \end{vmatrix} 4.0$	7 9 5		I 6, II		n _D =
7, 118.10	0. 4					

Inventor:

UNITED STATES PATENT OFFICE

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MICROSCOPE OBJECTIVE

Application filed February 8, 1929, Serial No. 338,452, and in Germany February 15, 1928.

The invention relates to microscope objec- and the thicknesses d refer to a focal length tives for subjective observation and for pro- of the system of 100 units. jection purposes with and without eyepiece, where a working distance which is specially long in relation to the focal length is desired. Such objective is obtained by composing a positive and a negative partial system, when the objective is applied in such a way that the positive partial system faces the object. 10 The purpose of application of such objectives requires a correction as complete as possible of the image forming defects in the axis, with regard to the spherical aberrations and their chromatic difference. In order to come up to 15 this requirement it is necessary to chromatically correct for itself each of the partial systems and, at the same time, to choose such kinds of glass for the single members that the difference of their ABBE figures v in each 20 partial system and at least between two single members is greater than 15, whereby the be spherically undercorrected. In order to further obtain a satisfactory elimination of 25 the image curvature, of the astigmatism and the distortion, it has proved to be of advantage to give the objective such a form that the surface having the strongest curvature, of one of the negative members belonging to the 30 back partial system faces the object. A further improvement can be attained in that way that the surface having the strongest curvature, also of one of the negative members belonging to the front partial system faces the 35 object.

The drawing represents in a longitudinal section an example of a microscope objective

corresponding to the invention.

The objective shown in the drawing consists of a front partial system comprising a collective lens I, a dispersive lens II, and a collective lens III, and of a back partial system comprising a dispersive lens IV and a kinds of glass used in each of both partial collective lens V. The values given in the systems being greater than 15, the front par-45 following tables for the radii r, the distance b, tial system being spherically undercorrected 90

Radii			Thick	Thicknesses and distances		
	1	$r_1 = +118.10$ $r_2 = -87.10$ $r_3 = -59.28$ $r_4 = -387.00$ $r_5 = +113.00$ $r_6 = -120.10$ $r_7 = -33.19$ $r_8 = \pm \infty$ $r_9 = +258.00$ $r_{10} = -101.00$	b ₁ = 4. d ₁₁ = 7. b ₂ = 0 d ₁₁₁ = 14. b ₃ = 99. d ₁ = 6. b ₄ = 1.	0 0 0 5 0		
		Kinds	s of glass			
	I	II	III	ıv	v	
n_{D}	1. 5163 64. 0	1.7174 29.5	1.6073 59.5	1. 6073 59. 5	1. 6200 36. 3	

I claim:

1. A microscope objective for long work-(front) partial system facing the object must ing distance consisting of a front positive be spherically undercorrected. In order to partial system and a back negative partial system, both partial systems being in themselves chromatically corrected, the difference 70 of the ABBE figures ν of at least two of the kinds of glass used in each of both partial systems being greater than 15, the front partial system being spherically undercorrected and comprising two positive lenses and a 75 negative lens, of which three lenses at least two have an air space between them, the back partial system being a single negative lens with a single positive lens behind, the said two negative lenses having the stronger 80 curvature on their front surface.

2. A microscope objective for long working distance consisting of a front positive partial system and a back negative partial system, both partial systems being in themselves chromatically corrected, the difference of the ABBE figures ν of at least two of the

and comprising two single positive lenses having a single negative lens between them, the back partial system being a single negative lens with a single positive lens behind, 5 the said two negative lenses having the stronger curvature on their front surface.

3. A microscope objective for long working distance consisting of a front positive partial system comprising two positive lenses and a negative lens, of which three lenses at least two have an air space between them, the said negative lens turning its stronger curved surface to the object-space, and of a back negative partial system con-15 sisting of a single negative lens which turns its stronger curved surface to the objectspace and has behind a single positive lens.

4. A microscope objective for long working distance consisting of a front positive 20 partial system comprising two single positive lenses having between them a single negative lens which turns its stronger curved surface to the object-space, and of a back negative partial system consisting of a sin-25 gle negative lens which turns its stronger curved surface to the object-space and has

behind a single positive lens.

5. A microscope objective for long working distance consisting of a front positive 30 partial system, composed of two single biconvex lenses having between them a single negative lens which turns its stronger curved surface to the object-space, and of a back negative partial system, consisting of a sin-85 gle negative lens which turns its stronger curved surface to the object-space and has behind a single bi-convex lens.

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